



Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty. Docket No. SCHO0056	Serial No.: 09/873,455
	Applicant: Staehler et al. Filing Date: June 4, 2001	Group: 2811

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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
<i>[Signature]</i>	A	6,153,076	11/28/2000	Davidson et al.	204	601	01/12/1998
<i>[Signature]</i>	B	5,783,452	07/21/1998	Jons et al.	436	183	02/02/1996

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	C	19940750	08/27/1999	Germany	33	48		X

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Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>[Signature]</i>	D	Chr. Burrer, and J. Esteve, <u>High-Precision BESOI-based Resonant Accelerometer</u> ; Sensors and Actuators; Elsevier Science S.A.; 1995
<i>[Signature]</i>	E	A. Benitez, J. Esteve, and J. Bausells; <u>Bulk Silicon Microelectromechanical Devices Fabricated From Commercial Bonded and Etched-Back Silicon-On-Insulator Substrates</u> ; Sensors and Actuators; Elsevier Science S.A.; 1995

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A	5,498,392	3/12/96	Wilding et al.	422	69.1	9/19/94
	B	5,744,366	4/28/98	Kricka et al.	436	63	11/14/94

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	C	WO 96/41864	12/27/96	PCT	C12M	1/02	X	
	D	WO 00/11477	3/2/00	PCT	G01N	33/60		X

Other Documents

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